MSKSEMI 美森科







TVS



TSS



MOV



GDT



PIFD

AONR21357

Product specification





Description

The AONR21357 uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

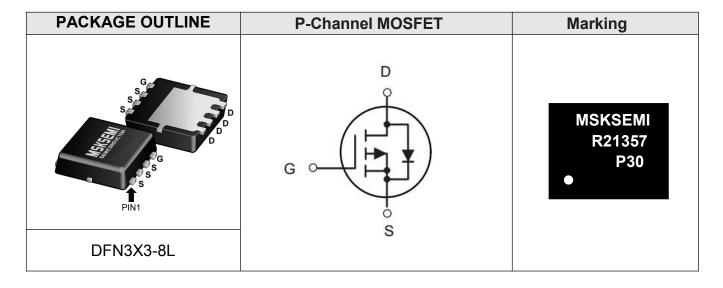
Features

- $V_{DS} = -30V$ $I_{D} = -50 A$
- $R_{DS(ON)} < 13m\Omega @ V_{GS}=-10V$

Application

- Battery protection
- Load switch
- Uninterruptible power supply

Reference News



Absolute Maximum Ratings (TC=25℃ unless otherwise specified)

			Rating		
Symbol	Parameter	10s	Steady State	Units	
VDS	Drain-Source Voltage	-30		V	
VGS	Gate-Source Voltage	±2	±20		
b@Tc=25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-5	-50		
b@Tc=100°C	Continuous Drain Current, V _{GS} @ -10V ¹	-2	-27		
b@Ta=25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-14.3	-9	А	
Ь@Та=70°С	Continuous Drain Current, V _{GS} @ -10V ¹	-11.4	-7.2	А	
IDM	Pulsed Drain Current ²	-130		А	
EAS	Single Pulse Avalanche Energy ³	125		mJ	
IAS	Avalanche Current	-50		А	
Pp@Tc=25°C	Total Power Dissipation ⁴	37		W	
Pd@Ta=25°C	Total Power Dissipation ⁴	4.2 1.67		W	
TSTG	Storage Temperature Range	-55 to 150		°C	
TJ	Operating Junction Temperature Range	-55 to 150		°C	



ReJA	Thermal Resistance Junction-Ambient ¹	75	°C/W
ReJA	Thermal Resistance Junction-Ambient ¹ (t ≤10s)	30	°C/W
ReJC	Thermal Resistance Junction-Case ¹	3.36	°C/W

Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ip=-250uA	-30			V
ΔBVDSS/ΔTJ	BVDSS Temperature Coefficient	Reference to 25°C , ID=-1mA		-0.0232		V/°C
Rds(on)	Static Drain-Source On-Resistance ²	Vgs=-10V , ID=-30A		9	13	mΩ
		Vgs=-4.5V , Ip=-15A		16	22	
V _{GS(th)}	Gate Threshold Voltage		-1.2		-2.5	V
ΔV GS(th)	V _{GS(th)} Temperature Coefficient	Vgs=Vps , Ip =-250uA		4.6		mV/°C
	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			-1	
loss		V _{DS} =-24V , V _{GS} =0V , T _J =55°C			-5	- uA
Igss	Gate-Source Leakage Current	Vgs= ±20V , Vps=0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-30A		30		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		9		Ω
Qg	Total Gate Charge (-4.5V)			22		
Qgs	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V , I _D =- 15A		8.7		nC
Qgd	Gate-Drain Charge	100		7.2		
Td(on)	Turn-On Delay Time			8		
Tr	Rise Time	V _{DD} =-15V V _{GS} =-10V		73.7		
T _{d(off)}	Turn-Off Delay Time	Rg=3.3		61.8		ns
Tf	Fall Time	ID=-15A		24.4		
Ciss	Input Capacitance			2215		
Coss	Output Capacitance	Vbs=-15V , Vgs=0V , f=1MHz		310		pF
Crss	Reverse Transfer Capacitance			237		
ls	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			-42	А
Isм	Pulsed Source Current ^{2,5}				-130	А
VsD	Diode Forward Voltage ²	V _G s=0V , I _S =-1A , T _J =25°C			-1	V
trr	Reverse Recovery Time	I _F =-15A , dI/dt=100A/μs ,		19		nS
Qrr	Reverse Recovery Charge	T _J =25°C		9		nC

Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed , pulse width ≤ 300 us duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is VDD =-25V VGS =-10V,L=0.1mH,IAS=-50A, 4.The power dissipation is limited by 150° Cjunction temperature
- 5. The data is theoretically the same as ID and IDM , in real applications, should be limited by total powedissipation.



Typical Characteristics

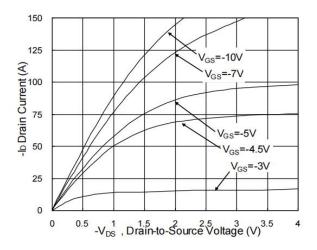


Fig.1 Typical Output Characteristics

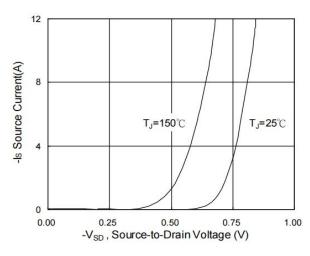


Fig.3 Forward Characteristics of Reverse

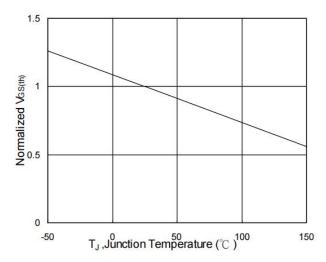


Fig.5 Normalized V_{GS(th)} vs. T_J

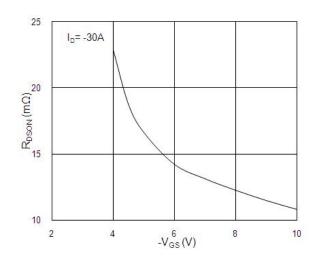


Fig.2 On-Resistance vs. G-S Voltage

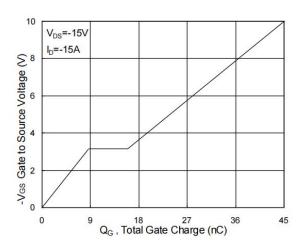


Fig.4 Gate-Charge Characteristics

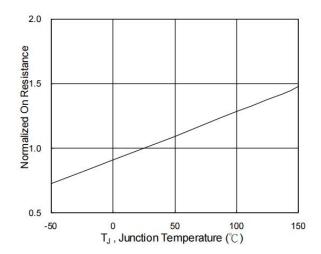
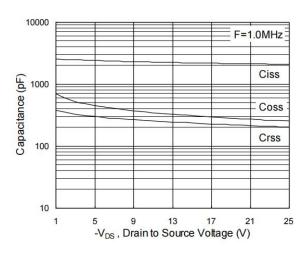


Fig.6 Normalized RDSON vs. TJ



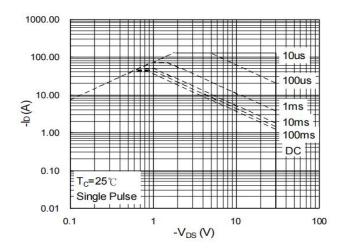


Fig.7 Capacitance

Fig.8 Safe Operating Area

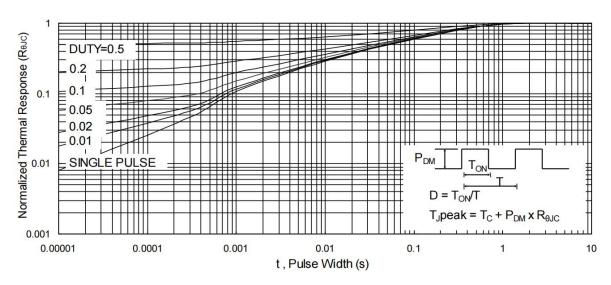
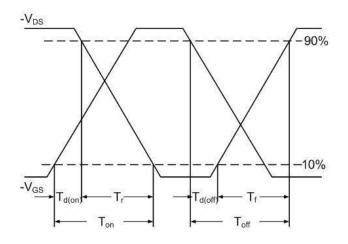
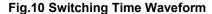


Fig.9 Normalized Maximum Transient Thermal Impedance





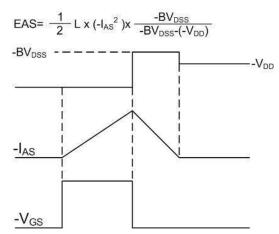
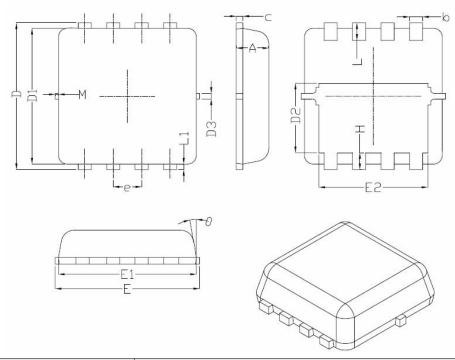


Fig.11 Unclamped Inductive Switching Waveform



DFN3X3-8L Package Information



Sumbal	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	<u>-</u>	0.13	_	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	_	0.13	-	
M	*	*	0.15	
θ		10 °	12 [°]	

REEL SPECIFICATION

P/N	PKG	QTY
AONR21357	DFN3X3-8L	5000



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DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B IPS60R3K4CEAKMA1 DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 IPS60R360PFD7SAKMA1
DMN2990UFB-7B SSM3K35CT,L3F IPLK60R1K0PFD7ATMA1 2N7002W-G MCAC30N06Y-TP IPWS65R035CFD7AXKSA1
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